

<b>Notice of References Cited</b>		Application/Control No. 10/815,564	Applicant(s)/Patent Under Reexamination BEATTY ET AL.	
		Examiner Leonardo Andújar	Art Unit 2826	Page 1 of 1

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*	B	US-6,756,251 B2	06-2004	Lee, Teck Kheng	438/108
*	C	US-6,653,743 B2	11-2003	Galuschki et al.	257/787
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	M	US-			

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**NON-PATENT DOCUMENTS**

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